



DMC4050SSD

40V COMPLEMENTARY PAIR ENHANCEMENT MODE MOSFET

Product Summary

			I _D Max
Device	V _{(BR)DSS}	R _{DS(ON)} Max	$T_A = +25^{\circ}C$
			(Notes 6 & 8)
Q1	40V	45mΩ @ V _{GS} = 10V	5.5A
QI	40 V	60mΩ @ V _{GS} = 4.5V	4.2A
Q2	40\/	45mΩ @ V _{GS} = -10V	-5.8A
	-40V	60mΩ @ V _{GS} = -4.5V	-4.2A

Features and Benefits

- Matched N & P R_{DS(ON)} Minimizes Power Losses
- Fast Switching Minimizes Switching Losses
- Dual Device Reduces PCB Area
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)

Description

This MOSFET is designed to ensure that $R_{DS(ON)}$ of N and P channel FET are matched to minimize losses in both arms of the bridge. The DMC4040SSD is optimized for use in 3-phase brushless DC motor circuits (BLDC), and CCFL backlighting.

Applications

- 3-Phase BLDC Motor
- CCFL Backlighting

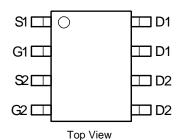
Mechanical Data

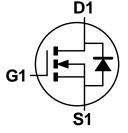
- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound.
 UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish Matte Tin Annealed over Copper Leadframe.
 Solderable per MIL-STD-202, Method 208 (2)
- Weight: 0.074 grams (Approximate)

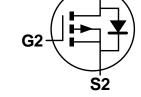
SO-8



Top View







D2

Equivalent Circuit

Ordering Information (Note 4)

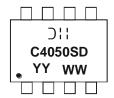
Product	Marking	Reel Size (inches)	Tape Width (mm)	Quantity per Reel
DMC4050SSD-13	C4050SD	13	12	2.500

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.



Marking Information



☐ Sharp Sha

Maximum Ratings (@T_A = +25°C, unless otherwise specified.)

Characteristic			Symbol	N-Channel - Q1	P-Channel - Q2	Units
Drain-Source Voltage			V_{DSS}	40	-40	V
Gate-Source Voltage	Gate-Source Voltage			±20	±20	1 v
		(Notes 6 & 8)		5.8	-5.8	
Continuous Drain Current	V _{GS} = 10V	T _A = +70°C (Notes 6 & 8)	I_D	4.38	-4.52	
Continuous Drain Current		(Notes 5 & 8)		4.2	-4.2	
		(Notes 5 & 9)		5.3	-5.3	Α
Pulsed Drain Current V _{GS} = 10V (Notes 7 & 8		(Notes 7 & 8)	I _{DM}	24.1	-24.9	
Continuous Source Current (Body Diode) (Notes 6 & 8)		(Notes 6 & 8)	Is	2.5	-2.5	
Pulsed Source Current (Body Diode) (Notes 7 & 8)		(Notes 7 & 8)	I _{SM}	24.1	-24.9	

Thermal Characteristics

Characteristic	Symbol	N-Channel - Q1 P-Channel - Q2	Unit		
Dower Dissipation	(Notes 5 & 8)		1.25 10		
Power Dissipation Linear Derating Factor	(Notes 5 & 9)	P _D	1.8 14.3	W mW/°C	
	(Notes 6 & 8)		2.14 17.2		
	(Notes 5 & 8)		100	°C/W	
Thermal Resistance, Junction to Ambient	(Notes 5 & 9)	$R_{\theta JA}$	70		
	(Notes 6 & 8)		58		
Thermal Resistance, Junction to Lead (Notes 5 & 10)		$R_{\theta JL}$	51		
Operating and Storage Temperature Range	T _J , T _{STG}	-55 to +150	°C		

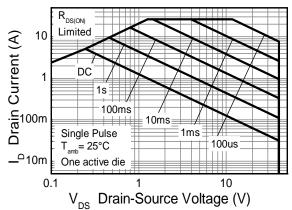
Notes:

- 5. For a device surface mounted on 25mm x 25mm x 1.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions; the device is measured when operating in a steady-state condition.
- 6. Same as note (5), except the device is measured at $t \leq 10 \mbox{ sec.}$
- 7. Same as note (5), except the device is pulsed with D = 0.02 and pulse width $300\mu s$.
- 8. For a dual device with one active die.
- 9. For a device with two active die running at equal power.
- 10. Thermal resistance from junction to solder-point (at the end of the drain lead).

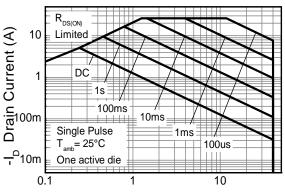
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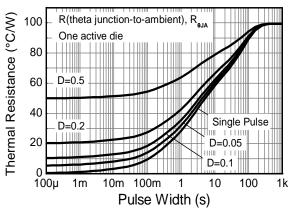
Thermal Characteristics (Continued)



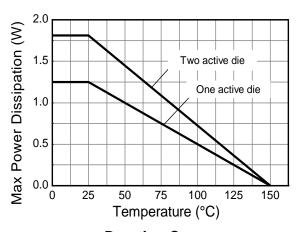
N-channel Safe Operating Area



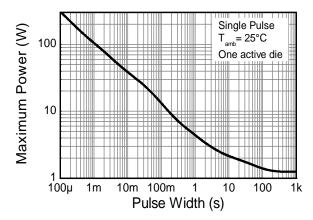
-V_{DS} Drain-Source Voltage (V) **P-channel Safe Operating Area**



Transient Thermal Impedance



Derating Curve



Pulse Power Dissipation



Electrical Characteristics (Q1 N-Channel) (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 11)							
Drain-Source Breakdown Voltage	BV _{DSS}	40	_		V	$V_{GS} = 0V, I_D = 250\mu A$	
Zero Gate Voltage Drain Current T _J = +25°C	I _{DSS}	_	_	1.0	μΑ	$V_{DS} = 40V$, $V_{GS} = 0V$	
Gate-Source Leakage	I _{GSS}	_	_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 11)							
Gate Threshold Voltage	V _{GS(th)}	8.0	1.3	1.8	V	$V_{DS} = V_{GS}$, $I_D = 250\mu A$	
Static Drain-Source On-Resistance	D-s/s/n		20	45	mΩ	$V_{GS} = 10V$, $I_D = 3A$	
Static Drain-Source Off-Nesistance	R _{DS(ON)}		33	60	11122	$V_{GS} = 4.5V, I_D = 3A$	
Forward Transfer Admittance	Y _{fs}	_	12.6		S	$V_{DS} = 5V, I_{D} = 3A$	
Diode Forward Voltage (Note 11)	V_{SD}	_	0.7	1.0	V	$V_{GS} = 0V$, $I_S = 1A$	
DYNAMIC CHARACTERISTICS (Note 12)							
Input Capacitance	C _{iss}	_	1790.8		pF	.,	
Output Capacitance	Coss	_	160.6		pF	$V_{DS} = 20V, V_{GS} = 0V,$ f = 1.0MHz	
Reverse Transfer Capacitance	C _{rss}	_	120.5		pF	1 = 1:000112	
Gate Resistance	R_g	_	1.03		Ω	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$	
Total Gate Charge	Qg	_	37.56		nC	V 40V V 20V	
Gate-Source Charge	Q_{gs}	_	7.8		nC	$V_{GS} = 10V, V_{DS} = 20V,$	
Gate-Drain Charge	Q_{gd}	_	6.6	_	nC	$I_D = 3A$	
Turn-On Delay Time	t _{D(on)}	_	8.08		nS		
Turn-On Rise Time	t _r	_	15.14		nS	$V_{GS} = 10V, V_{DS} = 20V,$	
Turn-Off Delay Time	t _{D(off)}	_	24.29		nS	$I_D = 3A$	
Turn-Off Fall Time	t _f	_	5.27	_	nS		

Electrical Characteristics (Q2 P-Channel) (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 11)				I .			
Drain-Source Breakdown Voltage	BV _{DSS}	-40	_	_	V	$V_{GS} = 0V, I_D = -250\mu A$	
Zero Gate Voltage Drain Current T _J = +25°C	I _{DSS}	1	_	-1.0	μΑ	V _{DS} = -40V, V _{GS} = 0V	
Gate-Source Leakage	I _{GSS}	_	_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 11)							
Gate Threshold Voltage	V _{GS(th)}	-0.8	-1.3	-1.8	٧	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	
Static Drain-Source On-Resistance			28	45	mΩ	$V_{GS} = -10V, I_D = -3A$	
Static Dialii-Source Oil-Resistance	R _{DS(ON)}		30	60	11122	$V_{GS} = -4.5V, I_{D} = -3A$	
Forward Transfer Admittance	Y _{fs}	1	16.6	_	S	$V_{DS} = -5V, I_{D} = -3A$	
Diode Forward Voltage (Note 11)	V_{SD}	1	-0.7	-1.0	V	$V_{GS} = 0V, I_{S} = -1A$	
DYNAMIC CHARACTERISTICS (Note 12)							
Input Capacitance	C _{iss}	1	1643.17		рF	N 00 V N 0 V	
Output Capacitance	C _{oss}	l	179.13	l	рF	$V_{DS} = -20V, V_{GS} = 0V,$ - f = 1.0MHz	
Reverse Transfer Capacitance	C _{rss}	1	127.82	-	pF	1 = 1.0WHZ	
Gate Resistance	Rg	1	6.43	_	Ω	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$	
Total Gate Charge	Qg	1	33.66	-	nC	10)/)/ 20)/	
Gate-Source Charge	Q _{gs}	_	5.54	_	nC	$V_{GS} = -10V, V_{DS} = -20V,$	
Gate-Drain Charge	Q _{gd}		7.30	_	nC	$I_D = -3A$	
Turn-On Delay Time	t _{D(on)}	_	6.85	_	nS		
Turn-On Rise Time	t _r		14.72	_	nS	$V_{GS} = -10V, V_{DS} = -20V,$ $I_{D} = -3A$	
Turn-Off Delay Time	t _{D(off)}	_	53.65	_	nS		
Turn-Off Fall Time	t _f	_	30.86	_	nS		

Notes:

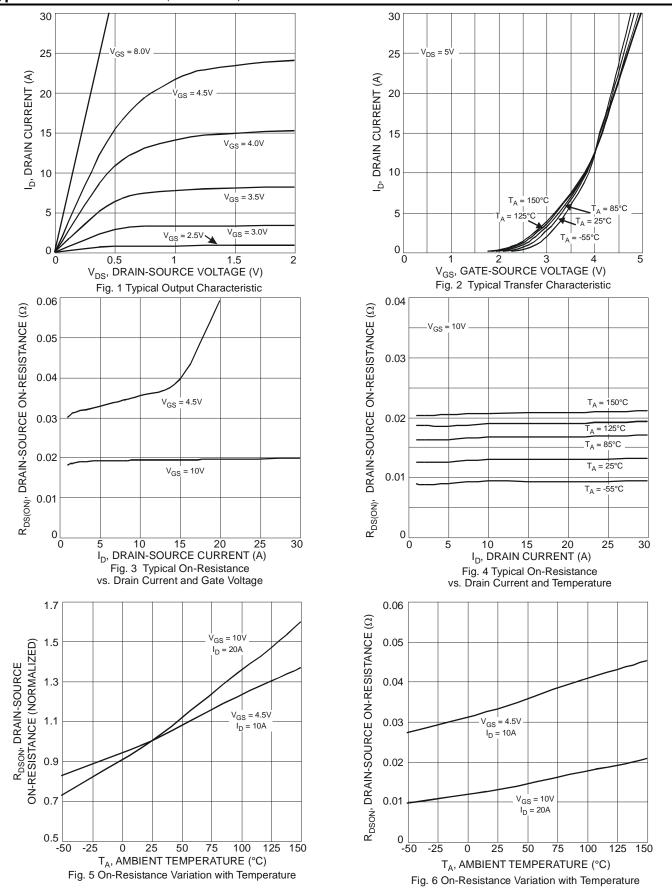
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^{11.} Short duration pulse test used to minimize self-heating effect.

^{12.} Guaranteed by design. Not subject to production testing.



Typical Characteristics (Q1 N-Channel)





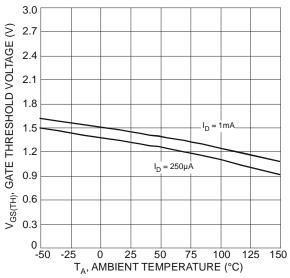
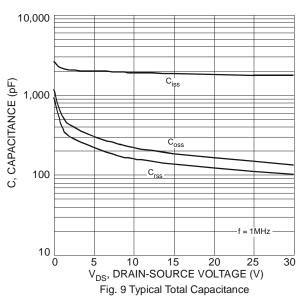
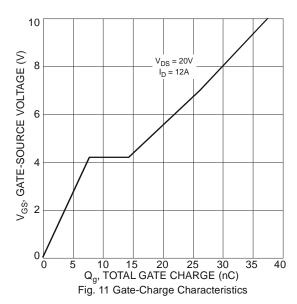
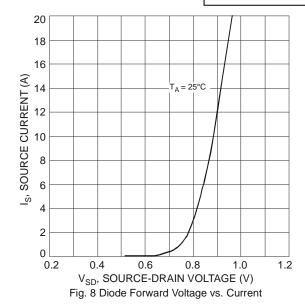
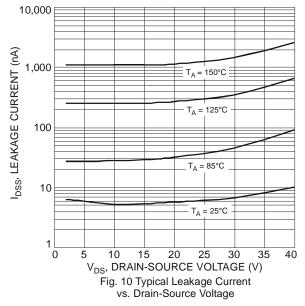


Fig. 7 Gate Threshold Variation vs. Ambient Temperature











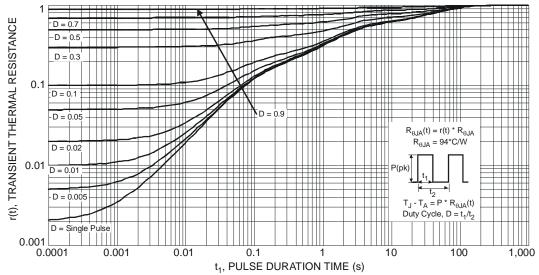
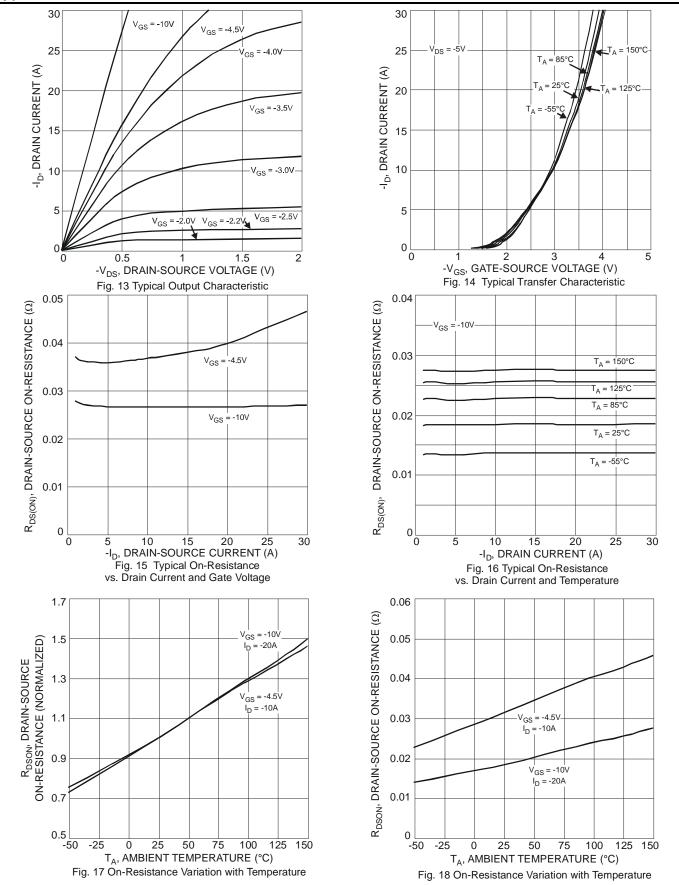


Fig. 12 Transient Thermal Response



Typical Characteristics (Q2 P-Channel)





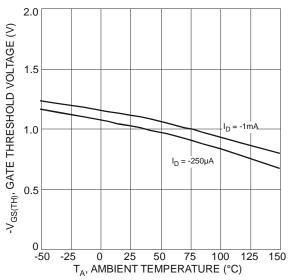
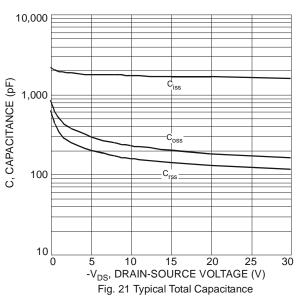
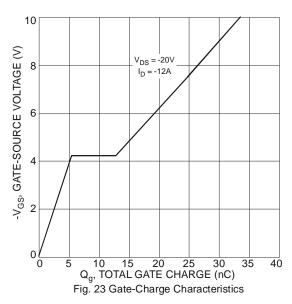


Fig. 19 Gate Threshold Variation vs. Ambient Temperature





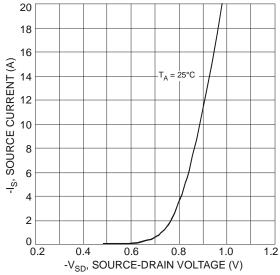
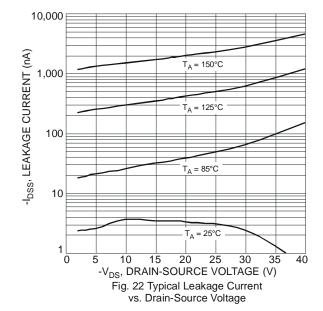


Fig. 20 Diode Forward Voltage vs. Current





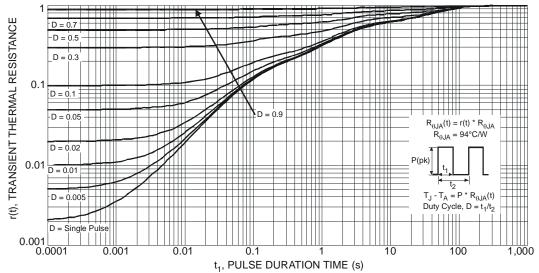


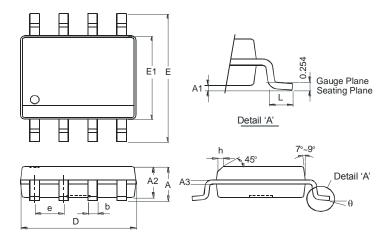
Fig. 24 Transient Thermal Response



Package Outline Dimensions

Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for the latest version.

SO-8

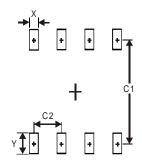


SO-8					
Dim	Min	Max			
Α	-	1.75			
A1	0.10	0.20			
A2	1.30	1.50			
A3	0.15	0.25			
b	0.3	0.5			
D	4.85	4.95			
E	5.90	6.10			
E1	3.85	3.95			
е	1.27 Typ				
h	-	0.35			
L	0.62	0.82			
θ	0°	8°			
All Dimensions in mm					

Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.

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Dimensions	Value (in mm)
Х	0.60
Y	1.55
C1	5.4
C2	1.27

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